

LuQY

The Absolute Luminescence Quantum Yield System: Plug and Play PL, PLQY & QFLS Measurements

When developing opto-electronic devices, such as LEDs or solar cells, it is essential to improve their radiative efficiency. This requires precise techniques to determine the luminescence quantum yield. The LuQY is an easy-to-use, non-invasive and versatile system with unparalleled compactness to swiftly quantify absolute photoluminescence fluxes of thin film absorbers, layer stacks or complete devices under various operating conditions.



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System & Layout





Swift quantification of **Absolute, Spectrally Resolved Photon Fluxes** from photoluminescence (**PL**) of semiconductor thin films & devices

USB-"Plug & Play": the included software records emission spectra & directly calculates **PL Quantum Yield & QFLS** (quasi-Fermi level splitting)

Small & Portable Layout allows flexible usage e.g. in gloveboxes

One-Click & High-Throughput Measurement

- Absolute number of photons from steady-state PL spectra (550-1000 nm)
- Automated, continuously adjustable laser intensity from 0.002-2 "Suns"
- PLQY sensitivity range: 1E-3%

Software & Applications







Records single or multiple PL spectra for pre-set laser intensity and voltage bias

Immediate calculation of PLQY & QFLS

Automated measurement sweeps

Directly constructs pseudo-JV and ideality factor plots by sweeping Laser intensity or bias voltage and determining the QFLS at each operating point.





Wavelength [nm]





Quality Assessment

Quality assessment for rapid **Process Control** after each fabrication step or for **Accelerated Material and Process Parameter Screenings.**

Transient Effects

Fast Acquisition resolves Shifts in Emission Spectrum & Intensity as well as PLQY and QFLS on timescales from 10 ms to several hours.

Resolve Bulk & Interface Recombination

Quantifying Bulk and Interface Recombination Losses in semiconductor thin films, layer stacks or complete devices such as solar cells or LEDs.

Efficiency Potentials & Loss Mechanisms

In-depth analysis of efficiency potentials and loss mechanisms in semiconductor thin films, layer stacks or full devices, e.g. determine Ideality Factors and Pseudo-JV Curves from Laser Intensity Dependent PLQY & QFLS.

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Technical Specifications & References



Technical Specifications

0.002 - 2 "Suns"

Spectral detection range 550 - 1000 nm Quantum yield sensitivity range 10-3 - 100%Corresponding min. resolvable iVoc for 1.6 eV absorber band gap 1.06 eV Spectrometer integration time 1 ms – 35 min Signal to noise ratio 600:1

Housing

Dimensions (L x W x H) Weight Connectors

220 x 390 x 130 mm 6.1 kg 1x DC, 1x USB 3.0

References

>10 publications using the LuQY Pro in renowned journals e.g.:

- Nature Energy -
- Joule -
- Advanced Energy Materials -
- ACS Applied Energy Materials -
- Advanced Functional Materials
- Progress in Photovoltaics
- Solar RRL



The LuQY can be integrated into SCIPRIOS' automated deposition systems e.g. the SpinBot. This allows high throughput screening and direct luminescence analysis of semiconductor stoichiometries, contact layers, deposition parameters, etc.

Contact

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Enhancing the efficiency and longevity of inverted

perovskite solar cells with antimony-doped tin oxides

Jia Li, Haoming Liang, Chuanxiao Xiao, Xiangkun Jia, Renjun Guo, Jinxi Chen, Xiao Guo, Ran Luo, Xi Wang,

Minghui Li, Michael Rossier, Alina Hauser, Flavio Linardi, Ezra Alvianto, Shunchang Liu, Jiangang Feng & Y

Laser

Spectrometer

Photoexcitation intensity (continuously adjustable) Photoexcitation wavelength Photoexcitation spot size

520 nm 0.5 cm²